Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/773,550	NAKANO ET AL.	
Examiner	Art Unit	
Chongshan Chen	2162	

SEARCHED					
Class	Subclass	Date	Examiner		
707	1	4/26/2005	cc		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
PALM	4/26/2005	СС
EAST search (USPAT, US-PGPUB, IBM_TDB)	4/26/2005	сс
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